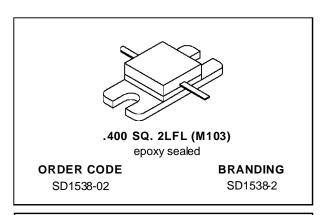
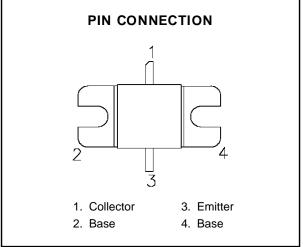


SD1538-02

RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 200 WATTS (typ.) IFF 1030 1090 MHz
- 150 WATTS (min.) DME 1025 1150 MHz
- 140 WATTS (typ.) TACAN 960 1215 MHz
- 7.8 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT/OUTPUT MATCHED, COMMON BASE CONFIGURATION





DESCRIPTION

The SD1538-02 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1538-02 is packaged in a metal/ceramic package with internal input/output matching resulting in improved broadband performance and a low thermal resistance.

ABSOLUTE MAXIMUM RATINGS $(T_{case} = 25^{\circ}C)$

Symbol	Parameter	Value	Unit	
V _{CBO}	Collector-Base Voltage	65	V	
V _{CES}	Collector-Emitter Voltage	65	V	
V _{EBO}	Emitter-Base Voltage	3.5	V	
Ic	Device Current	11.0	А	
P _{DISS}	Power Dissipation	583	W	
TJ	Junction Temperature	+200	°C	
T _{STG}	Storage Temperature	- 65 to +150	°C	

THERMAL DATA

R _{TH(j-c)} Junction-Case Thermal Resistance	0.30	°C/W
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ELECTRICAL SPECIFICATIONS (Tcase = 25°C)

STATIC

Symbol	Test Conditions	Value			Unit		
		rest Conditions	Min.	Тур.	Max.		
ВУсво	I _C = 10mA	$I_E = 0mA$		65	_	_	V
BVces	I _C = 25mA	$V_{BE} = 0V$		65	_	_	V
BV _{EBO}	I _E = 5mA	$I_C = 0mA$		3.5	_	_	V
I _{CES}	V _{CE} = 50V	$I_E = 0mA$		_	_	10	mA
hFE	Vce = 5V	Ic = 300mA		5	_	_	_

DYNAMIC

Symbol	Test Conditions		Value		
Symbol			Тур.	Max.	Unit
Pout	f = 1025 — 1150MHz P _{IN} = 25.0 W V _{CE} = 50 V	150	_	_	W
G_P	f = 1025 — 1150MHz P _{IN} = 25.0 W V _{CE} = 50 V	7.8	_	_	dB

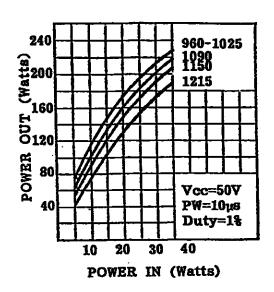
Note: Pulse Width = 10μ Sec, Duty Cycle = 1%

This device is suitable for use under other pulse width/duty cycle conditions.

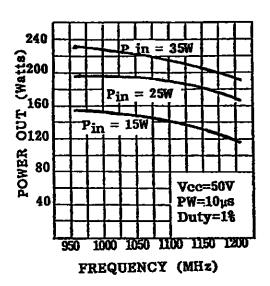
Please contact the factory for specific applications assistance.

TYPICAL PERFORMANCE

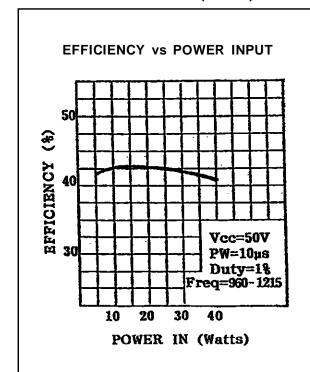
POWER OUTPUT vs POWER INPUT

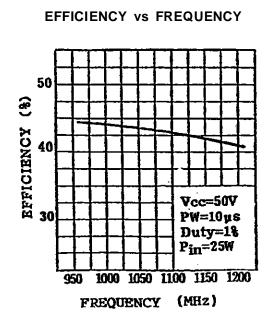


POWER OUTPUT vs FREQUENCY

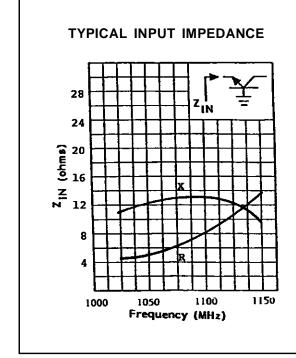


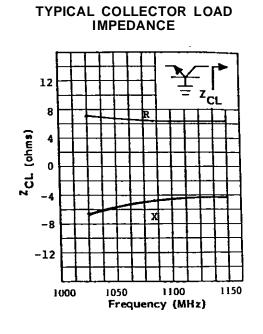
TYPICAL PERFORMANCE (cont'd)



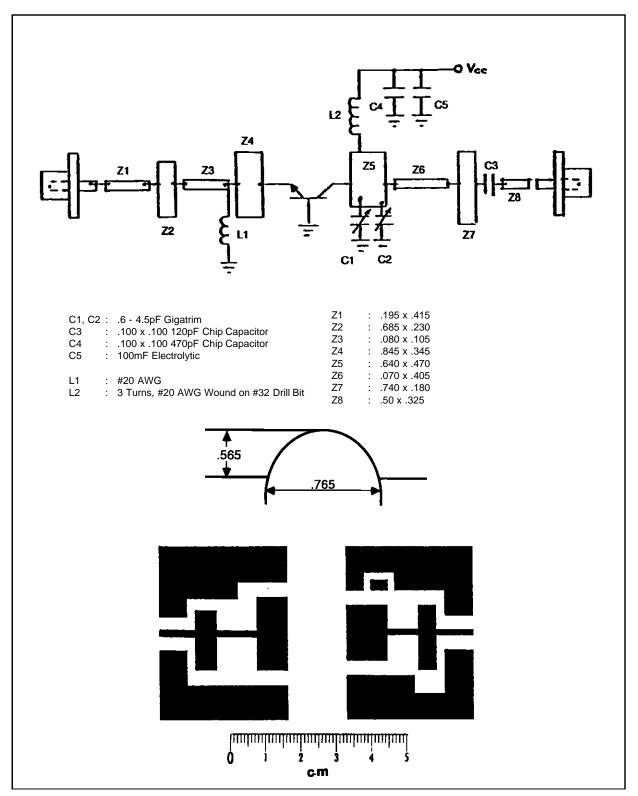


IMPEDANCE DATA

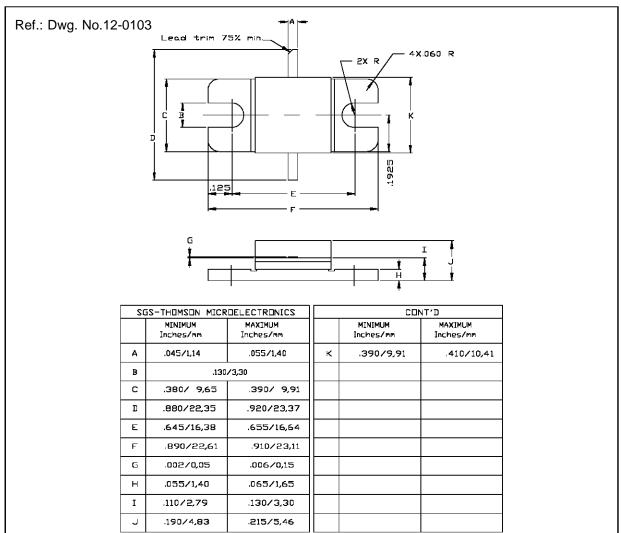




TEST CIRCUIT AND PC BOARD LAYOUT



PACKAGE MECHANICAL DATA



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